

Search Notes 	Application/Control No.	Applicant(s)/Patent Under Reexamination
	09645646	HAYASHI ET AL.
	Examiner	Art Unit
	Vo, Hai	1771

SEARCHED

Class	Subclass	Date	Examiner
428	319.3, 319.7, 319.9, 317.9	04/27/2007	HV
15	all	04/27/2007	HV
134	all	04/27/2007	HV

SEARCH NOTES

Search Notes	Date	Examiner

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner